

## TRADEMARK ASSIGNMENT

Electronic Version v1.1  
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SUBMISSION TYPE:	NEW ASSIGNMENT		
NATURE OF CONVEYANCE:	ASSIGNS THE ENTIRE INTEREST AND THE GOODWILL		
CONVEYING PARTY DATA			
Name	Formerly	Execution Date	Entity Type
Endicott Interconnect Technologies, Inc.		02/12/2013	CORPORATION: NEW YORK
RECEIVING PARTY DATA			
Name:	Kromek Acquisition Corporation		
Street Address:	c/o The Kromek Group, Thomas Wright Way		
City:	Sedgefield, County Durham		
State/Country:	UNITED KINGDOM		
Postal Code:	TS21 3FD		
Entity Type:	CORPORATION: DELAWARE		
PROPERTY NUMBERS Total: 10			
Property Type	Number	Word Mark	
Registration Number:	1826237	EV PRODUCTS	
Registration Number:	3376495	EV-CZT	
Registration Number:	3442375	EV-MULTIPIX	
Registration Number:	3509949	MAKING EVERY EVENT COUNT	
Registration Number:	3599462	ISPECTRUM	
Registration Number:	3635790	EVASIC	
Registration Number:	3648582	EVALUATOR	
Registration Number:	3648583	EV-CPG	
Registration Number:	3728801	IGEM	
Serial Number:	85793752	CAPTURE	
CORRESPONDENCE DATA			
Fax Number:	3129855963		
<i>Correspondence will be sent to the e-mail address first; if that is unsuccessful, it will be sent</i>			

OP \$265.00 1826237

*via US Mail.*

Phone: 312-985-5900  
Email: mkitz@clarkhill.com  
Correspondent Name: Clark Hill PLC  
Address Line 1: 150 North Michigan Ave.  
Address Line 2: Suite 2700  
Address Line 4: Chicago, ILLINOIS 60601

ATTORNEY DOCKET NUMBER:	40310/156346
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**DOMESTIC REPRESENTATIVE**

Name:  
Address Line 1:  
Address Line 2:  
Address Line 3:  
Address Line 4:

NAME OF SUBMITTER:	James A. O'Malley
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Signature:	/James A. O'Malley/
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Date:	02/18/2013
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Total Attachments: 8  
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## INTELLECTUAL PROPERTY ASSIGNMENT

WHEREAS, ENDICOTT INTERCONNECT TECHNOLOGIES, INC., a corporation organized and existing under the laws of the State of New York, having its principal place of business at 1093 Clark Street, Endicott, New York 13761 and KROMEK ACQUISITION CORPORATION, a corporation organized and existing under the laws of the State of Delaware, having its principal place of business c/o The Kromek Group, Thomas Wright Way, Sedgfield, County Durham, UK, TS21 3FD, have executed an Asset Purchase Agreement ("Asset Purchase Agreement") dated January 15, 2013.

WHEREAS, pursuant to the Asset Purchase Agreement, ENDICOTT INTERCONNECT TECHNOLOGIES, INC. and KROMEK ACQUISITION CORPORATION have executed an Intellectual Property Assignment Agreement ("IP Agreement") whereby ENDICOTT INTERCONNECT TECHNOLOGIES, INC. has agreed to assign and transfer its entire right, title and interest in the Intellectual Property Rights identified on Schedule B to the IP Agreement ("Intellectual Property Rights") to KROMEK ACQUISITION CORPORATION.

NOW, THEREFORE, TO ALL WHOM IT MAY CONCERN: Be it known that, in consideration of the covenants and agreements contained in the Asset Purchase Agreement and the IP Agreement, and other good and valuable consideration, the receipt and sufficiency of which are hereby acknowledged, ENDICOTT INTERCONNECT TECHNOLOGIES, INC. ("Assignor") does hereby absolutely, unconditionally and irrevocably transfer, convey and assign to KROMEK ACQUISITION CORPORATION ("Assignee"), its successors and assigns, for, within and through the United States and the territories thereof, and all foreign countries, all of Assignor's right, title and interest in, to and under, including, but not limited to, all of Assignors' common law rights, and all obligations under or relating to, the Intellectual Property Rights, together with the right to sue for past infringement thereof, and all of the goodwill of the business symbolized by the Intellectual Property Rights. The Intellectual Property Rights identified on Schedule B to the IP Agreement are reproduced and identified on Exhibit A attached hereto.

Assignor further does hereby covenant and agree, for itself and its successors and assigns, that, following the execution of this Assignment, it will assist Assignee in vesting in Assignee like exclusive title in and to all the Intellectual Property Rights, and that it will execute and deliver to Assignee any and all additional papers that may be requested by Assignee to fully carry out the terms of this Assignment. In no event, however, shall Assignor be responsible for payment of examination, prosecution, issue, publication, recording, foreign agent, patent office, or maintenance, or annuity fees relating to the Intellectual Property Rights upon execution of this Assignment unless otherwise agreed to by Assignor and Assignee.

*INTELLECTUAL PROPERTY ASSIGNMENT*

**TRADEMARK**  
**REEL: 004965 FRAME: 0558**

IN WITNESS WHEREOF, I have hereunto set my hand and seal this 12<sup>th</sup> day of February, 2013.

Endicott Interconnect Technologies, Inc.

By: James J. McNamara Jr.  
Name: James J. McNamara Jr.  
Title: President and CEO

STATE OF New York )  
 )  
COUNTY OF Broome )

This 12<sup>th</sup> day of February, 2013, before me personally came the above-named James McNamara Jr., to me personally known as the President & CEO of Endicott Interconnect Technologies, Inc. and as the individual who executed the foregoing assignment and acknowledged to me that (he/she) executed the same of (his/her) own free will for the purposes therein set forth.

Bethany Justofin  
Notary Public

(Notarial Seal)

BETHANY JUSTOFIN  
NOTARY PUBLIC STATE OF NEW YORK  
BROOME COUNTY  
LIC. #01546189167  
MY COMMISSION EXPIRES JULY 8, 14

INTELLECTUAL PROPERTY ASSIGNMENT

Exhibit A

[attached]

Doc. No.	Docket No.	Country	Title	Inventor(s)	Filing Date	Appl. No.	Publication No.	Issued	Pub. No.	Status
	EE-EV-907981	US	HIGH-SPEED PULSE DISCRIMINATING GAMMA RAY CAMERA	V. Vydrin R. Davis J. Groshech K. Parrham	10/24/2000	602242,942				Converted
	EE-EV-911239	PCT	HIGH-SPEED PULSE DISCRIMINATING GAMMA RAY CAMERA	V. Vydrin R. Davis J. Groshech K. Parrham	10/24/2001	PCT/US2001/045094	WFO 2002-057807			Done
	EE-EV-926936	Japan	HIGH-SPEED PULSE DISCRIMINATING GAMMA RAY CAMERA	V. Vydrin R. Davis J. Groshech K. Parrham	10/24/2001	2002-558035		11/22/2007	4044439	Issued
	EE-EV-926637	US	HIGH-SPEED PULSE DISCRIMINATING GAMMA RAY CAMERA	V. Vydrin R. Davis J. Groshech K. Parrham	9/26/2003	10/269,510	2004-012667	9/9/2005	6,927,366	Issued
	EE-EV-971689	US	COINTE DEVICE FOR USING CONSTRAINED DESIGN FOR HIGH-FLUX X-RAY SPECTROSCOPIC IMAGING APPLICATIONS	V. Vydrin D. Bole S. Sakher C. Szabes	9/6/2007	60287,898				Converted
	EE-EV-987946	US	COINTE DEVICE USING CONSTRAINED DESIGN FOR HIGH-FLUX X-RAY SPECTROSCOPIC IMAGING APPLICATIONS	D. Bole S. Sakher C. Szabes	9/8/2008	12/204,929	2009-066791	4/27/2010	7,705,319	Issued
	EE-EV-970341	US	CORRECTION METHOD FOR PHOTON COUNTING IMAGING SYSTEM	D. Runkle	9/22/2007	60295,848				Converted
	EE-EV-987688	PCT	CORRECTION METHOD FOR PHOTON COUNTING IMAGING SYSTEM	D. Runkle	9/29/2008	PCT/US2008/078117	WFO 2009-043003			Done
	EE-EV-990188	US	COUNT UNIFORMITY CORRECTION IN FLUX SPACE FOR PXLATED SEMICONDUCTING RADIATION DETECTORS	D. Bole	3/15/2006	60782,464				Converted
	EE-EV-97287	PCT	COUNT UNIFORMITY CORRECTION IN FLUX SPACE FOR PXLATED SEMICONDUCTING RADIATION DETECTORS	D. Bole	3/19/2007	PCT/US2007/018934	WFO 2007-109039			Done
	EE-EV-982561	US	COUNT UNIFORMITY CORRECTION IN FLUX SPACE FOR PXLATED SEMICONDUCTING RADIATION DETECTORS	D. Bole	9/4/2008	12/281,586	2009-0614680	12/18/2009	7,653,068	Issued
	EE-EV-960273	US	CCPMS RECIFE FOR SEMIINSULATING COXEM(X)TEO-X <sub>1</sub> -F1 FOR RADIATION DETECTOR APPLICATIONS	C. Szabes S. Cameron V. Malhera U. Chakrabarti	1/27/2005	607647,598				Converted
	EE-EV-960040	PCT	RADIATION DETECTOR CRYSTAL AND METHOD OF FORMATION THEREOF	C. Szabes S. Cameron V. Malhera U. Chakrabarti	1/27/2006	PCT/US2006/003162	WFO 2006-101532			Done
	EE-EV-962621	US	RADIATION DETECTOR CRYSTAL AND METHOD OF FORMATION THEREOF	C. Szabes S. Cameron V. Malhera U. Chakrabarti	1/27/2006	10/594,934	2009-0641648	11/20/2009	7,812,845	Issued

Doc. No.	Country	Title	Inventor(s)	Filing Date	Appl. No.	Publication No.	Issued	Patent No.	Status
EI-EV-072408	EPC	RADIATION DETECTOR CRYSTAL AND METHOD OF FORMATION THEREOF	C. Szekes S. Cameron V. Maffera U. Chakrabarti	7/20/2007	867138831.3	EP1842853			Pending
EI-EV-072408	Japan	RADIATION DETECTOR CRYSTAL AND METHOD OF FORMATION THEREOF	C. Szekes S. Cameron V. Maffera U. Chakrabarti	12/7/2006	2007-453310				
EI-EV-072409	Israel	RADIATION DETECTOR CRYSTAL AND METHOD OF FORMATION THEREOF	C. Szekes S. Cameron V. Maffera U. Chakrabarti	7/18/2007	164732				
EI-EV-076216	China	ENERGY COMPENSATION SHIELD FOR CRTE- AND COINTE-BASED DOSIMETERS	D. Bale	2/15/2007	210720092250.5	CN400196839		200720092250.5	Pending
EI-EV-080133	US	ENERGY DISCRIMINATING SCATTER IMAGING SYSTEM	D. Bale	8/18/2006	80931,845				Converted
EI-EV-081474	PCT	ENERGY DISCRIMINATING SCATTER IMAGING SYSTEM	D. Bale	8/18/2006	PC/77,523,960/2007.17	WO 2106,136821			Done
EI-EV-074595	US	ENERGY DISCRIMINATING SCATTER IMAGING SYSTEM	D. Bale	8/26/2006	1,015,581	2006-0263283	5/18/2010	7,738,531	Issued
EI-EV-073788	US	FIRST AND SECOND MOMENT COUNT CORRECTION METHOD	C. Szekes	6/19/2008	64873,562				Converted
EI-EV-081735	US	INFRARED LIGHT STIMULATED HIGH-FLUX SEMICONDUCTOR X-RAY AND GAMMA-RAY RADIATION DETECTOR WITH IMPROVED TEMPORAL RESPONSE AND POLARIZATION THRESHOLD	C. Szekes M. Probst D. Bale B. Glick C. Crawford	9/26/2008	61100,358				Converted
EI-EV-081736	US	INFRARED LIGHT STIMULATED HIGH-FLUX SEMICONDUCTOR X-RAY AND GAMMA-RAY RADIATION DETECTOR	C. Szekes M. Probst D. Bale B. Glick C. Crawford	9/25/2008	125865,888	2010-0678359			Pending
EI-EV-081734	US	INFRARED LIGHT STIMULATED COINTE SPECTROSCOPIC SEMICONDUCTOR X-RAY AND GAMMA-RAY RADIATION DETECTOR WITH IMPROVED AND EXTENDED OPERATING TEMPERATURE RANGE	M. Probst C. Szekes	9/26/2008	61100,364				Converted
EI-EV-081734	US	INFRARED LIGHT STIMULATED COINTE SPECTROSCOPIC SEMICONDUCTOR X-RAY AND GAMMA-RAY RADIATION DETECTOR	M. Probst C. Szekes	9/25/2008	12656,666	2010-0078658			Pending
EI-EV-080179	US	ILLUMINATED VARIABLE GAP G-6 GRID DEVICE STRUCTURE	S. Sommer	4/21/2006	60783,917				Converted
EI-EV-073632	PCT	ILLUMINATED VARIABLE GAP G-6 GRID DEVICE STRUCTURE	S. Sommer	4/28/2007	PCT/US2007/021181	WO 2008-054882			Issued
EI-EV-082981	US	RADIATION DETECTOR WITH COPANOR GRID STRUCTURE	S. Sommer	10/20/2008	1,929,747	2009-0299538	2/24/2009	7,705,221	Issued
EI-EV-081152	US	HIGH PERFORMANCE COINTE IN EQUAL TO OR LESS THAN X EQUAL TO METHOD OF MANUFACTURE THEREOF	C. Szekes	5/16/2008	60684,381				Converted
EI-EV-080446	PCT	HIGH PERFORMANCE COINTE IN EQUAL TO OR LESS THAN X EQUAL TO METHOD OF MANUFACTURE THEREOF	C. Szekes	5/16/2008	PCT/US2008/018779	WO 2007-024302			Done

Discl. No.	Docket No.	Country	Title	Inventor(s)	Filing Date	Appl. No.	Publication No.	Issued	Patent No.	Status
	EP-EV-045237	Israel	RADIATION DETECTOR	C. Szekes K. Lynn	6/19/2003	186586				Issued
	EP-EV-046238	EPC	RADIATION DETECTOR	C. Szekes K. Lynn	6/19/2003	3731605.6	EP-1535309	1/12/2008	1535309	Issued
	EP-EV-081872	EPC	RADIATION DETECTOR	C. Szekes K. Lynn	6/19/2003	2086075223	EP-1853804			
	EP-EV-031988	PCT	RADIATION DETECTOR	C. Szekes H. Vidyasath	1/10/2003	PCT/US2003/005728	WO 2003-048357			Done
	EP-EV-081444	US	RADIATION DETECTOR	C. Szekes H. Vidyasath	9/19/2007	106781057	2007-0193507			Pending
	EP-EV-081166	Japan	RADIATION DETECTOR	C. Szekes H. Vidyasath	11/10/2003	2005-510846				Pending
	EP-EV-061168	Israel	RADIATION DETECTOR	C. Szekes H. Vidyasath	11/10/2003	175584				Pending
	EP-EV-071592	US	SEMICONDUCTOR RADIATION DETECTOR WITH THIN FILM PLATINUM ALLOYED ELECTRODE	G. Smith	1/23/2008	671022.836				Converted
	EP-EV-083284	US	SEMICONDUCTOR RADIATION DETECTOR WITH THIN FILM PLATINUM ALLOYED ELECTRODE	G. Smith C. Szekes	1/23/2008	121581063	2008-0218647			Pending
	EP-EV-081529	US	STAGGERED ARRAY IMAGING SYSTEM USING PIXELATED RADIATION DETECTORS	V. Vyrtin	5/21/2006	506591007				Converted
	EP-EV-072110	US	STAGGERED ARRAY IMAGING SYSTEM USING PIXELATED RADIATION DETECTOR	V. Vyrtin	6/22/2007	116881843	2008-0135785	12/29/2008	7,538,775	Issued
	EP-EV-072118	PCT	STAGGERED ARRAY IMAGING SYSTEM USING PIXELATED RADIATION DETECTOR	V. Vyrtin	8/6/2007	PCT/US2007/075349	WO 2008-024611			Done
	EP-EV-072517	US	VARIABLE PIXEL PITCH X-RAY IMAGING SYSTEM	D. Ruelle	9/28/2007	809851847				Converted
	EP-EV-083300	PCT	VARIABLE PIXEL PITCH X-RAY IMAGING SYSTEM	D. Ruelle	8/26/2008	PCT/US2008/077281	WO 2009-042827			Pending
	EP-EV-083976	PCT	CORRECTION METHOD FOR PHOTON COUNTING IMAGING SYSTEM	C. Ruelle	6/11/2009	PCT/US2009/047623	WO 2009-155198			Done
	EP-EV-081973-US	US	COUNT CORRECTION IN A PHOTON COUNTING IMAGING SYSTEM	D. Ruelle	7/29/2010	19988, 316	2011-0191231-41			Pending
	EP-2-13-004	US	METHOD OF MAKING A SEMICONDUCTOR RADIATION DETECTOR	M. Prokash H. Li J. Eger	4/10/2012	13942, 857				Filed



Doc. No.	Doclet No.	Country	Title	Inventor(s)	Filing Date	Appl. No.	Publication No.	Issued	Patent No.	Status
	EP-EV-473335	China	HIGH PERFORMANCE COZINATE (OR EQUAL TO OR LESS THAN X EQUAL TO OR LESS THAN 1) X-RAY AND GAMMA RAY RADIATION DETECTOR AND METHOD OF MANUFACTURE THEREOF	C. Szalas	5/16/2008	200804016866.5				Pending
	EP-EV-473341	Japan	HIGH PERFORMANCE COZINATE (OR EQUAL TO OR LESS THAN X EQUAL TO OR LESS THAN 1) X-RAY AND GAMMA RAY RADIATION DETECTOR AND METHOD OF MANUFACTURE THEREOF	C. Szalas	5/16/2008	2008-512412				Pending
	EP-EV-483156	US	MULTI-WINDOW SIGNAL PROCESSING ELECTRONICS ARCHITECTURE FOR PHOTON COUNTING WITH MULTI-ELEMENT SENSORS	J. Grosholz	3/22/2006	68766,481				Converted
	EP-EV-470286	PCT	MULTI-WINDOW SIGNAL PROCESSING ELECTRONICS ARCHITECTURE FOR PHOTON COUNTING WITH MULTI-ELEMENT SENSORS	J. Grosholz P. O'Connor G. Degenerano	3/22/2007	PCT/US2007/007659	WO 2007-111912			Done
	EP-EV-482945	US	MULTI-WINDOW SIGNAL PROCESSING ELECTRONICS ARCHITECTURE FOR PHOTON COUNTING WITH MULTI-ELEMENT SENSORS	J. Grosholz P. O'Connor G. Degenerano	1/8/2008	12,622,867	2008-0502232			Pending
	EP-EV-471338	US	PORTABLE GAMMA RAY SPECTROSCOPY MODULE	F. Ferraro	10/11/2007	50579,114				Converted
	EP-EV-482633	US	PORTABLE RADIATION DETECTION SYSTEM AND METHOD	F. Ferraro R. Davis J. Grosholz	10/9/2008	12,649,358	2008-0098815			Pending
	EP-EV-480286	US	RADIATION DETECTION SYSTEM WITH IMPROVED SIGNAL DISCRIMINATION AND METHOD OF USE THEREOF	V. Vachekshv	5/15/2005	68860,982				Converted
	EP-EV-480648	PCT	RADIATION DETECTION SYSTEM WITH IMPROVED SIGNAL DISCRIMINATION AND METHOD OF USE THEREOF	V. Vachekshv R. Davis D. Rands	5/7/2006	PCT/US2006/008331	WO 2006-091003			Done
	EP-EV-472646	Israel	RADIATION DETECTION SYSTEM WITH IMPROVED SIGNAL DISCRIMINATION AND METHOD OF USE THEREOF	D. Rands R. Davis V. Vachekshv	3/7/2006	185204				Pending
	EP-EV-481634	US	RADIATION DETECTOR ASSEMBLY	P. Sognesest S. Kraama F. Ferraro	2/4/2004	10,058,071	2004-0818913	8/21/2005	6,808,100	Issued
	EP-EV-481738	PCT	RADIATION DETECTOR ASSEMBLY	F. Sognesest S. Kraama F. Ferraro	2/4/2004	PCT/US2004/003553	WO 2004-078786			Done
	EP-EV-482348	Israel	RADIATION DETECTOR ASSEMBLY	P. Sognesest S. Kraama F. Ferraro	2/4/2004	170102				Pending
	EP-EV-481136	US	RADIATION DETECTOR WITH ASYMMETRIC CONTACTS	C. Szalas	4/7/2008	8,104,234				Converted
	EP-EV-481134	US	RADIATION DETECTOR	K. Lynn	8/19/2002	60397,881				Converted
	EP-EV-486726	PCT	RADIATION DETECTOR	C. Szalas K. Lynn	6/10/2003	PCT/US2003/015225	WO 2003-105497			Done
	EP-EV-486536	US	RADIATION DETECTOR	C. Szalas K. Lynn	7/27/2006	10,518,799	2006-0558341	3/20/2007	7,192,481	Issued
	EP-EV-485536	Japan	RADIATION DETECTOR AND METHOD OF MAKING THE SAME	C. Szalas K. Lynn	6/10/2003	2004-512175		8/7/2009	4353483	Issued

Trademark/Service Mark	Country	Filing Date	Application No.	Registration No.	Registration Date
eV PRODUCTS and Design	US	6/10/1993	74/400,625	1,826,237	3/15/1994
making eVery eVent count	US	7/29/2005	78/681,248	3,509,949	9/30/2008
eV-CZT	US	7/29/2005	78/681,261	3,376,495	1/29/2008
IGEM	US	12/1/2006	77/054,783	3,728,801	12/22/2009
ISPECTRUM	US	10/12/2007	77/302,437	3,599,462	3/31/2009
eV-CPG	US	5/14/2008	77/474,322	3,648,583	6/30/2009
eVALUATOR	US	5/14/2008	77/474,302	3,648,582	6/30/2009
CAPTURE	US	12/4/2012	85/793,752		
eVASIC	US			3,635,790	6/9/2009
eV-MultiPIX	US	7/29/2005	78/681,252	3,442,375	6/3/2008